

September 2008

FDMA410NZ

Single N-Channel 1.5 V Specified PowerTrench® MOSFET 20 V, 9.5 A, 23 m Ω

Features

- Max $r_{DS(on)}$ = 23 m Ω at V_{GS} = 4.5 V, I_D = 9.5 A
- Max $r_{DS(on)}$ = 29 m Ω at V_{GS} = 2.5 V, I_D = 8.0 A
- Max $r_{DS(on)}$ = 36 m Ω at V_{GS} = 1.8 V, I_D = 4.0 A
- Max $r_{DS(on)} = 50 \text{ m}\Omega$ at $V_{GS} = 1.5 \text{ V}$, $I_D = 2.0 \text{ A}$
- HBM ESD protection level > 2.5 kV (Note 3)
- Low Profile-0.8 mm maximum in the new package MicroFET 2x2 mm
- RoHS Compliant

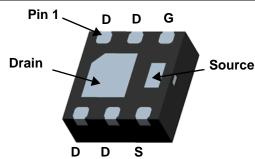


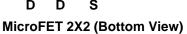
General Description

This Single N-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench process to optimize the $r_{\text{DS(ON)}}$ @ V_{GS} = 1.5 V on special MicroFET leadframe.

Applications

■ Li-Ion Battery Pack





D 1 6 D D 2 5 D G 3 4 S

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Paramo	Ratings	Units		
V_{DS}	Drain to Source Voltage			20	V
V_{GS}	Gate to Source Voltage			±8	V
	-Continuous	T _A = 25 °C	(Note 1a)	9.5	Δ.
I _D	-Pulsed			24	Α
D	Power Dissipation	T _A = 25 °C	(Note 1a)	2.4	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1b)	0.9	VV
T _J , T _{STG}	Operating and Storage Junction Tempera	ture Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	52	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	145	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
410	FDMA410NZ	MicroFET 2X2	7 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	lest Conditions	IVIII	тур	IVIAX	Units
Off Chara	acteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to 25 °C		17		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	0.4	0.7	1.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-3		mV/°C
	$V_{GS} = 4.5 \text{ V}, I_D = 9.5 \text{ A}$		17	23		
		$V_{GS} = 2.5 \text{ V}, I_D = 8.0 \text{ A}$		20	29	
r	Static Drain to Source On Resistance	$V_{GS} = 1.8 \text{ V}, I_D = 4.0 \text{ A}$		24	36	mΩ
r _{DS(on)}	Claud Drain to Gource On Resistance	$V_{GS} = 1.5 \text{ V}, I_D = 2.0 \text{ A}$		29	50	11152
		$V_{GS} = 4.5 \text{ V}, I_D = 9.5 \text{ A},$ $T_J = 125 ^{\circ}\text{C}$		23	32	
9 _{FS}	Forward Transconductance	$V_{DD} = 5 \text{ V}, I_{D} = 9.5 \text{ A}$		35		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 40.V.V 0.V	815	1080	pF
C _{oss}	Output Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	130	175	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12	85	130	pF
R_g	Gate Resistance	f = 1 MHz	2.1		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			7.5	15	ns
t _r	Rise Time	$V_{DD} = 10 \text{ V}, I_D = 9.5 \text{ A},$		3.9	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$		27	44	ns
t _f	Fall Time			3.7	10	ns
Qg	Total Gate Charge	V 45V V 40V		10	14	nC
Q _{gs}	Gate to Source Charge	V _{GS} = 4.5 V , V _{DD} = 10 V, I _D = 9.5 A		1.2		nC
Q_{gd}	Gate to Drain "Miller" Charge	ID = 3.3 A		2.0		nC

Drain-Source Diode Characteristics

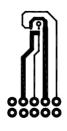
I _S	Maximum Continuous Drain-Source Diode Forward Current				2.0	Α
V_{SD}	Source to Drain Diode Forward Voltage V _{GS} = 0 V, I _S = 2.0 A (Note 2)			0.7	1.2	V
t _{rr}	Reverse Recovery Time	I _E = 9.5 A, di/dt = 100 A/μs		12	22	ns
Q _{rr}	Reverse Recovery Charge	I _F = 9.5 A, αι/αι = 100 A/μs		2.6	10	nC

NOTES:

^{1.} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0JA} is determined by the user's board design.



a.52 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 145 °C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 μs , Duty cycle < 2.0%.

^{3.} The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

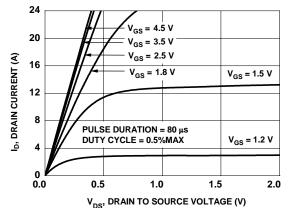


Figure 1. On-Region Characteristics

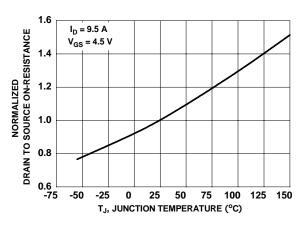


Figure 3. Normalized On-Resistance vs Junction Temperature

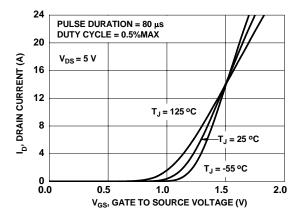


Figure 5. Transfer Characteristics

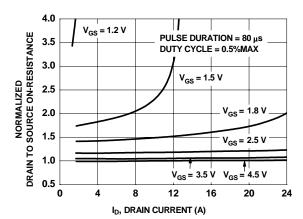


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

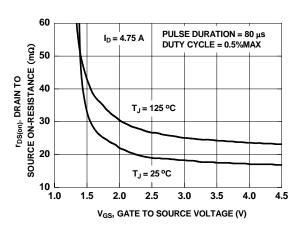


Figure 4. On-Resistance vs Gate to Source Voltage

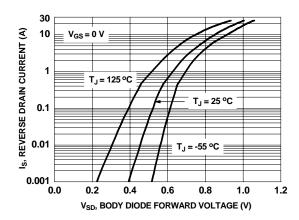


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

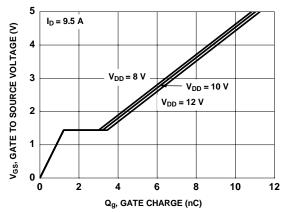


Figure 7. Gate Charge Characteristics

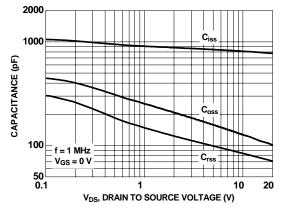


Figure 8. Capacitance vs Drain to Source Voltage

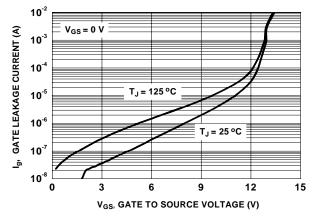


Figure 9. Gate Leakage Current vs Gate to Source Voltage

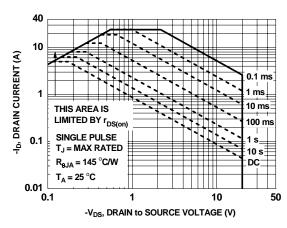


Figure 10. Forward Bias Safe Operation Area

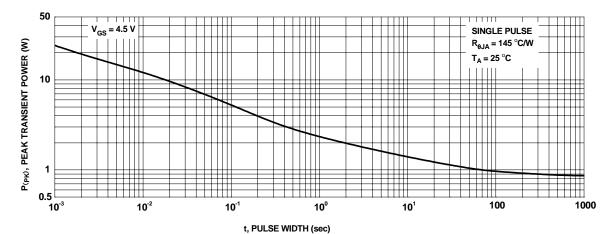


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

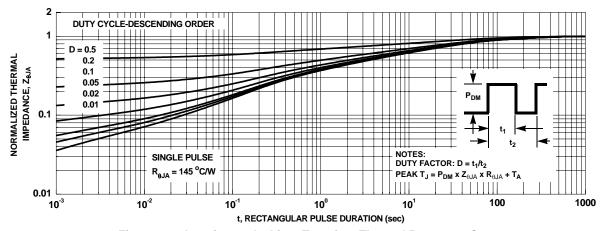
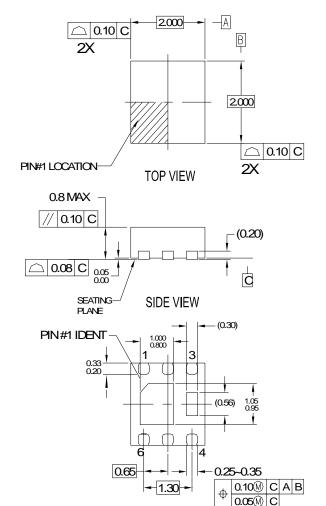
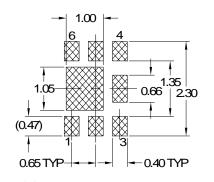


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout



RECOMMENDED LAND PATTERN OPT 1



RECOMMENDED LAND PATTERN OPT 2

BOTTOM VIEW

NOTES:

- A DOES NOT FULLY CONFORM TO JEDEC REGISTRATION MO-229 DATED AUG/2003
- B. DIMENSIONS ARE INMILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- D. DRAWING FILENAME: MKT-MLP06Lrev2.



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